



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Re the Application of

Hogan *et al.*

Appln. No.: 10/635,824

Filed: 08-06-2003

For: Method for Improving Ash Rate Uniformity in Photoresist Ashing Process  
Equipment

Docket No.: TI-28996.1

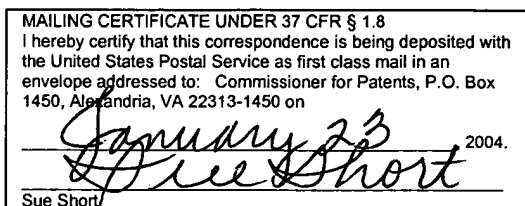
Art Unit: 3742

Examiner:

Conf. No.: 7653

January 18, 2004

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450



**INFORMATION DISCLOSURE STATEMENT**

Dear Sir:

The Applicants wish to bring to the attention of the Patent and Trademark Office the information noted on the enclosed form PTO/SB/08A that may be considered material to the examination of the above-identified application.

No fee is due at this time, as this Information Disclosure Statement is being filed pursuant to 37 C.F.R. § 1.97(b)(3), before the mailing of a first Office Action on the merits.

Respectfully submitted,

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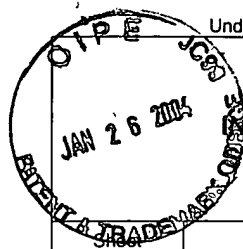
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PTO/SB/08A (05-03)

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Substitute for Form 1449A/PTO

# **INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

(use as many sheets as necessary)

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of

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## **Complete If Known**

<b>Application Number</b>	10/635,824
<b>Filing Date</b>	08-06-2003
<b>First Named Inventor</b>	Timothy J. Hogan <i>et al.</i>
<b>Group Art Unit</b>	3742
<b>Examiner Name</b>	
<b>Attorney Docket No.</b>	TI-28996.1

## **U.S. PATENT DOCUMENTS**

Exam. Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code <sup>2</sup> (if known)			
	AA	4,873,445		Le Jeune	10-10-1989	
	AB	5,248,371		Maher <i>et al.</i>	09-28-1993	
	AC	5,266,146		Ohno <i>et al.</i>	11-30-1993	
	AD	5,948,283		Grosshart	09-07-1999	
	AE	6,087,615		Schork <i>et al.</i>	07-11-2000	
	AF	6,230,650	B1	Yamazaki	05-15-2001	

## **FOREIGN PATENT DOCUMENTS**

Exam. Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>2</sup>
		Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>2</sup> (if known)				
	BA							
	BB							
	BC							

## **OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS**

Exam. Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	CA		
	CB		
	CC		

Examiner Signature		Date Considered	
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup>Unique citation designation number. <sup>2</sup>Applicant is to place a check mark here if English Translation is attached.